Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	pplicant(s)/Patent under eexamination	
10/673,444	KONDO, TAKAYUKI		
Examiner	Art Unit		

2874

PHAN T.H. PALMER

	SEARCHED				
Class	Subclass	Date	Examiner		
385	14, 15, 27, 37, 88, 89, 129,	11/16/2005	PTHP		
385	130, 147	11/16/2005	PTHP		
398	082	11/16/2005	PTHP		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

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